Freescale Semiconductor

Technical Data

Document Number: AFV141KH

Rev. 0, 4/2016



RF Power LDMOS Transistors

High Ruggedness N-Channel Enhancement-Mode Lateral MOSFETs

These RF power devices are designed for commercial applications operating at frequencies from 1200 to 1400 MHz such as commercial L-Band radars. The devices are suitable for use in pulse applications.

Typical Pulse Performance: In 1200–1400 MHz reference circuit, V_{DD} = 50 Vdc, $I_{DQ(A+B)}$ = 100 mA, P_{in} = 25 W

Frequency (MHz)	Signal Type	P _{out} (W)	G _{ps} (dB)	η _D (%)
1200	Pulse (300 μsec, 12% Duty Cycle)	950 Peak	15.8	46.5
1300	(coo pood, 12% buty cycle)	1120 Peak	16.5	47.5
1400		1000 Peak	16.1	46.6

Load Mismatch/Ruggedness

Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage	Result
1400 (1)	Pulse (128 μsec,	> 20:1 at All Phase	31.6 Peak (3 dB	50	No Device Degradation
	10% Duty Cycle)	Angles	Overdrive)		

^{1.} Measured in 1400 MHz narrowband production circuit.

Features

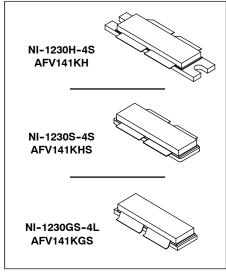
- Internally Input and Output Matched for Broadband Operation and Ease of Use
- Device Can Be Used in a Single-Ended, Push-Pull or Quadrature Configuration
- Qualified up to a Maximum of 50 V_{DD} Operation
- High Ruggedness, Handles > 20:1 VSWR
- Integrated ESD Protection with Greater Negative Voltage Range for Improved Class C Operation and Gate Voltage Pulsing
- · Characterized with Series Equivalent Large-Signal Impedance Parameters

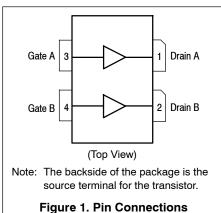
Typical Applications

· Commercial L-Band Radar Systems

AFV141KH AFV141KHS AFV141KGS

1200–1400 MHz, 1000 W PEAK, 50 V AIRFAST RF POWER LDMOS TRANSISTORS





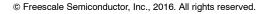




Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +105	Vdc
Gate-Source Voltage	V _{GS}	-6.0, +10	Vdc
Storage Temperature Range	T _{stg}	-65 to +150	°C
Case Operating Temperature Range	T _C	-40 to +150	°C
Operating Junction Temperature Range (1,2)	TJ	-40 to +225	°C
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	910 4.55	W W/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Impedance, Junction to Case Case Temperature 60°C, 1000 W Peak, 128 μsec Pulse Width, 10% Duty Cycle, 50 Vdc, I _{DQ(A+B)} = 100 mA, 1400 MHz	Z _{θJC}	0.018	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2, passes 2500 V
Machine Model (per EIA/JESD22-A115)	B, passes 200 V
Charge Device Model (per JESD22-C101)	IV, passes 2000 V

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics ⁽⁴⁾					
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	_	1	μAdc
Drain-Source Breakdown Voltage (V_{GS} = 0 Vdc, I_D = 10 μ Adc)	V _{(BR)DSS}	105	_	_	Vdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 50 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	1	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 105 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	10	μAdc
On Characteristics					
Gate Threshold Voltage ⁽⁴⁾ (V _{DS} = 10 Vdc, I _D = 520 μAdc)	V _{GS(th)}	1.3	1.8	2.3	Vdc
Gate Quiescent Voltage ⁽⁵⁾ (V _{DD} = 50 Vdc, I _{DQ(A+B)} = 100 mAdc, Measured in Functional Test)	V _{GS(Q)}	1.6	2.1	2.6	Vdc
Drain-Source On-Voltage (4) (V _{GS} = 10 Vdc, I _D = 2.6 Adc)	V _{DS(on)}	0.05	0.16	0.35	Vdc
Dynamic Characteristics (5)					
Reverse Transfer Capacitance (V _{DS} = 50 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{rss}	_	2.98	_	pF

- 1. Continuous use at maximum temperature will affect MTTF.
- 2. MTTF calculator available at http://www.nxp.com/RF/calculators.
- 3. Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to http://www.nxp.com/RF and search for AN1955.
- 4. Each side of device measured separately.
- 5. Measurement made with device in push-pull configuration.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) (continued)

	Characteristic		nbol	Min	Тур	Max	Unit

Functional Tests (1,2) (In Freescale Narrowband Production Test Fixture, 50 ohm system) V_{DD} = 50 Vdc, I_{DQ(A+B)} = 100 mA, P_{out} = 1000 W Peak (100 W Avg.), f = 1400 MHz, 128 μsec Pulse Width, 10% Duty Cycle

Power Gain	G _{ps}	16.0	17.7	19.5	dB
Drain Efficiency	η _D	46.0	52.1		%
Input Return Loss	IRL	_	-18	–9	dB

$\textbf{Load Mismatch/Ruggedness} \text{ (In Freescale Narrowband Test Fixture, 50 ohm system) } \textbf{I}_{DQ(A+B)} = 100 \text{ mA}$

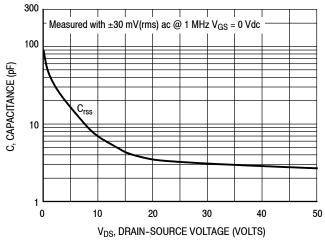
Frequency (MHz)	Signal Type	VSWR	P _{in} (W)	Test Voltage, V _{DD}	Result
1400	Pulse (128 μsec, 10% Duty Cycle)	> 20:1 at all Phase Angles	31.6 Peak (3 dB Overdrive)	50	No Device Degradation

Table 5. Ordering Information

Device	Tape and Reel Information	Package
AFV141KHR5		NI-1230H-4S, Eared
AFV141KHSR5	R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel	NI-1230S-4S, Earless
AFV141KGSR5		NI-1230GS-4L, Gull Wing

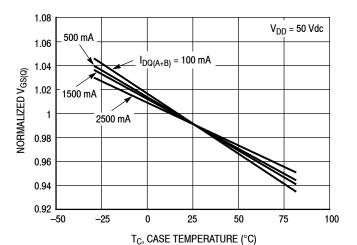
- 1. Measurement made with device in push-pull configuration.
- 2. Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GS) parts.

TYPICAL CHARACTERISTICS



Note: Each side of device measured separately.

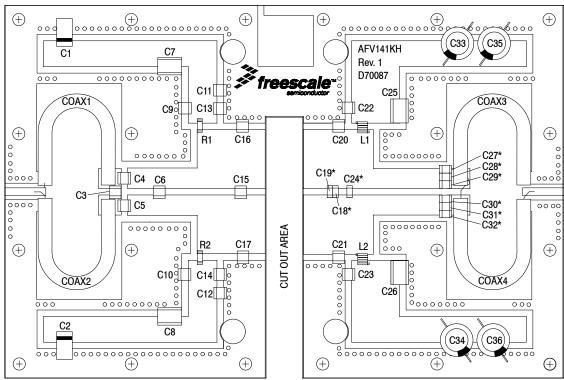
Figure 2. Capacitance versus Drain-Source Voltage



I _{DQ} (mA)	Slope (mV/°C)
100	-2.06
500	-1.96
1500	-1.94
2500	-1.72

Figure 3. Normalized $V_{\mbox{\scriptsize GS}}$ versus Quiescent Current and Case Temperature

1400 MHz NARROWBAND PRODUCTION TEST FIXTURE — 4" × 6" (10.2 cm × 15.2 cm)



^{*} C18, C19, C24, C27, C28, C29, C30, C31 and C32 are mounted vertically.

Figure 4. AFV141KH(HS) Narrowband Test Circuit Component Layout — 1400 MHz

Table 6. AFV141KH(HS) 1400 MHz Narrowband Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2	22 μF, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C3	2.7 pF Chip Capacitor	ATC100B2R7BT500XT	ATC
C4, C5, C9, C10, C13, C14, C22, C23	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C6	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C7, C8	2.2 μF Chip Capacitors	C1825C225J5RACTU	Kemet
C11, C12	0.1 μF Chip Capacitors	CDR33BX104AKY9S	AVX
C15	2.2 pF Chip Capacitor	ATC100B2R2BT500XT	ATC
C16, C17	0.7 pF Chip Capacitors	ATC100B0R7BT500XT	ATC
C18	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C19	1.2 pF Chip Capacitor	ATC100B1R2BT500XT	ATC
C20, C21	2.2 pF Chip Capacitors	ATC100B2R2BT500XT	ATC
C24	1.5 pF Chip Capacitor	ATC100B1R5BT500XT	ATC
C25, C26	0.01 μF Chip Capacitors	C1825C103K1GACTU	Kemet
C27, C28, C29, C30, C31, C32	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C33, C34, C35, C36	470 μF, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
Coax1, Coax2, Coax3, Coax4	35 Ω Semi Rigid Coax 1.454" Shield Length	HSF-141-35-C	Hongsen Cable
L1, L2	17.5 nH, 4 Turn Inductors	GA3095-ALC	Coilcraft
R1, R2	100 Ω, 1 W Chip Resistors	CRCW2512100RFKEG	Vishay
PCB	Arlon AD255A, 0.03", $\epsilon_r = 2.55$	D70087	MTL

AFV141KH AFV141KHS AFV141KGS

TYPICAL CHARACTERISTICS — 1400 MHz PRODUCTION TEST FIXTURE

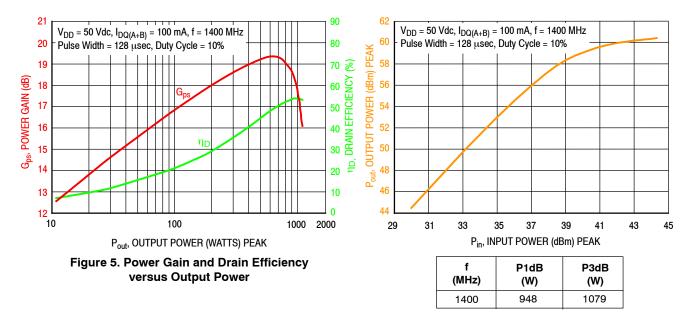


Figure 6. Output Power versus Input Power

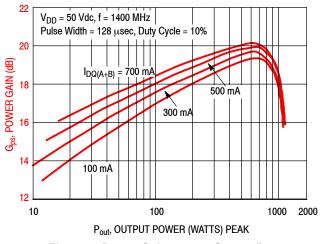


Figure 7. Power Gain versus Output Power

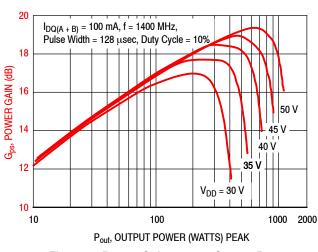


Figure 8. Power Gain versus Output Power

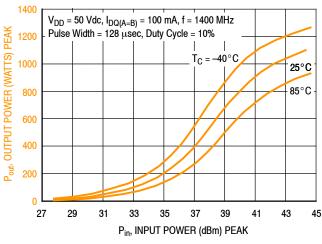


Figure 9. Output Power versus Input Power

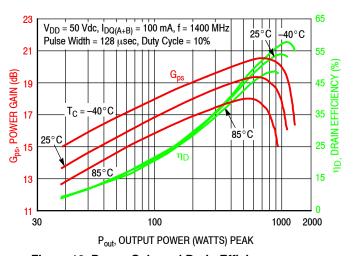


Figure 10. Power Gain and Drain Efficiency versus
Output Power

1400 MHz NARROWBAND PRODUCTION TEST FIXTURE

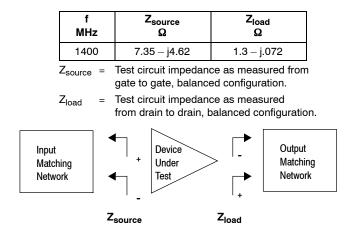
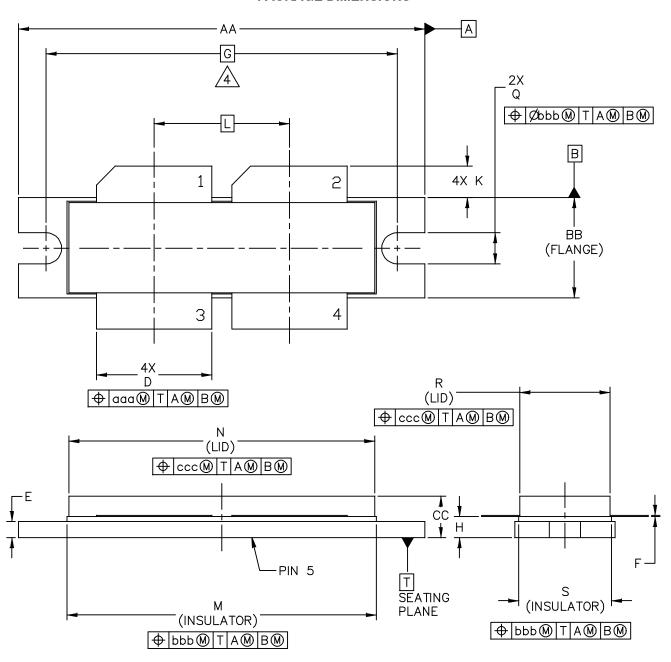


Figure 11. Narrowband Series Equivalent Source and Load Impedance — 1400 MHz

PACKAGE DIMENSIONS



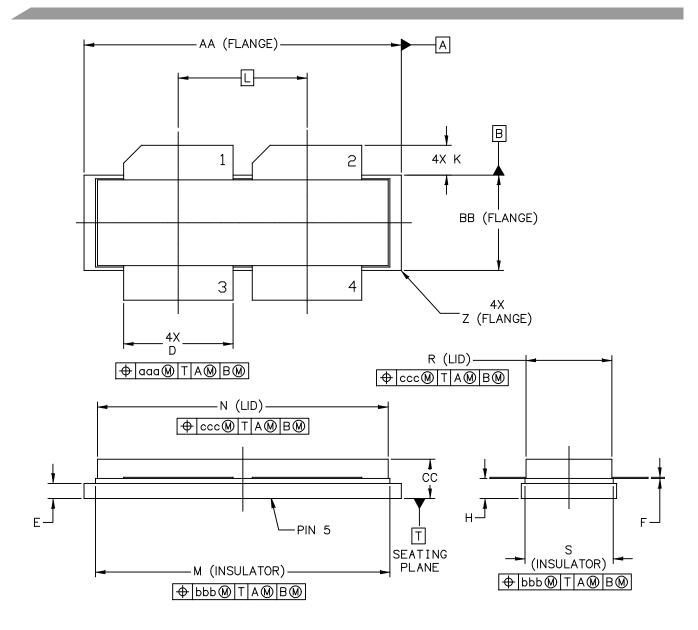
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TITLE:		DOCUME	NT NO: 98ASB16977C	REV: G	
NI-1230-4H		STANDAF	RD: NON-JEDEC		
		S0T1787	−1 03	3 MAR 2016	

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH
- 3. DIMENSION H IS MEASURED . 030 INCH (0.762 MM) AWAY FROM PACKAGE BODY.

4 RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

	INCH		MILL	IMETER			INCH		METER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX	
AA	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55	
BB	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.30	
CC	.170	.190	4.32	4.83	R	.355	.365	9.02	9.27	
D	.455	.465	11.56	11.81	s	.365	.375	9.27	9.53	
Е	.062	.066	1.57	1.68						
F	.004	.007	0.10	0.18						
G	1.400	BSC	35.	56 BSC	aaa		.013		33	
Н	.082	.090	2.08	2.29	bbb		.010	0.25		
K	.117	.137	2.97	3.48	ccc		.020	0.51		
L	.540	BSC	13.7	72 BSC						
М	1.219	1.241	30.96	31.52						
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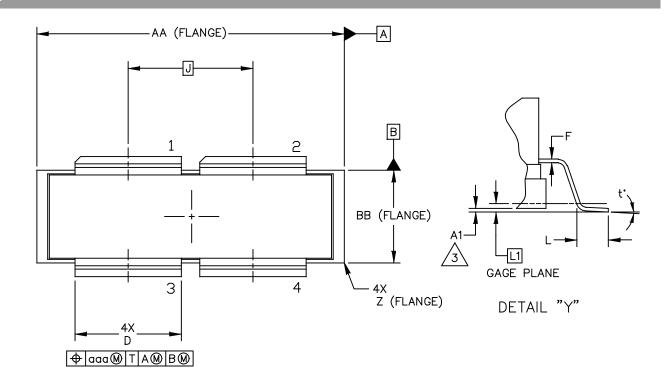


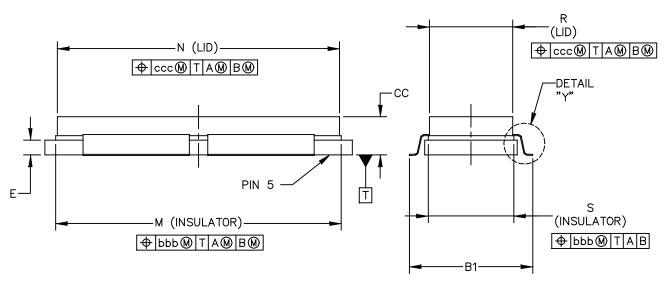
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NI-1230-4S		STANDAF	RD: NON-JEDEC		
		S0T1829	9–1	19 FEB 2016	

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH
- 3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY

DIM	INC MIN	HES MAX	MILI MIN	LIMETERS MAX	DIM	NIM II	INCHES MIN MAX		METERS MAX		
AA	1.265	1.275	32.13	32.39	R	.355	.365	9.02	9.27		
BB	.395	.405	10.03	10.29	S	.365	.375	9.27	9.53		
СС	.170	.190	4.32	4.83	Z	R.000	R.040	R0.00	R1.02		
D	.455	.465	11.56	11.81							
E	.062	.066	1.57	1.68	aaa		.013	0.	.33		
F	.004	.007	0.10	0.18	bbb		.010 0.25		.25		
Н	.082	.090	2.08	2.29	ccc		.020		.020 0.51		.51
K	.117	.137	2.97	3.48							
L	L .540 BSC		13.	72 BSC							
М	1.219	1.241	30.96	31.52							
N	1.218	1.242	30.94	31.55							
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		S0T1806	5–2	23 FEB 2016

NOTES:

- 1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH



DIMENSION A1 IS MEASURED WITH REFERENCE TO DATUM T. THE POSITIVE VALUE IMPLIES THAT THE PACKAGE BOTTOM IS HIGHER THAN THE LEAD BOTTOM.

DIM	INC MIN	HES MAX	MIL MIN	LIMETERS MAX	DIM	MIN I	NCHES MAX	MILLIN MIN	METERS MAX
AA	1.265	1.275	32.13	32.39	R	.355	.365	9.02	9.27
A1	001	.011	-0.03	0.28	S	.365	.375	9.27	9.53
BB	.395	.405	10.03	10.29	Z	R.000	R.040	R0.00	R1.02
B1	.564	.574	14.32	14.58	t.	0.	8.	0.	8*
СС	.170	.190	4.32	4.83					
D	.455	.465	11.56	11.81	aaa		.013	0.33	
E	.062	.066	1.57	1.68	bbb		.010 0.25		.25
F	.004	.007	0.10	0.18	ccc		.020	0.51	
J	.540	BSC	13.	72 BSC					
L	.038	.046	0.97	1.17					
L1	.01	BSC	0.	25 BSC					
М	1.219	1.241	30.96	31.52					
N	1.218	1.242	30.94	31.55					
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	NI-1230-4S GULL						STANDARD: NON-JEDEC		
						S0T1806	5-2	2.	3 FEB 2016

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- · AN1908: Solder Reflow Attach Method for High Power RF Devices in Air Cavity Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

· Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

- 1. Go to http://www.nxp.com/RF
- 2. Search by part number
- 3. Click part number link
- 4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

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	0	Apr. 2016	Initial Release of Data Sheet
	-		

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